Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S77	15615	(Taiwan near Semiconductor).as.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 10:56
S78	96656	Kao.in. or Chang.in. or Yu-Ping	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 10:56
S79	25118343	((@ad<"20030912") or (@rlad<"20030912"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:44
S80	597995	(critical near dimension) or CD!	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 10:57
S81	47703	(measur\$4 same feed\$2back same control\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 10:58
S82	1051224	(etch\$4 or pattern\$4 or photolitho\$4 or remov\$4 or creat\$4) near8 (opening or trench or groove or recess or via or hole)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 10:59
S83	110147	S77 or S78	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/12/27 10:59
S84	3	S83 and S80 and S81 and S82	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 11:00

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S85	832	S80 and S81 and S82	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 11:00
S86	607	S85 and S79	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 11:08
S87	9	(control\$4 near20 feedback near20 opening) same (resist or photoresist)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:43
S88	2390	(measur\$4 or check\$4) near8 (critical near dimension)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:44
S89	2017	S88 and (etch\$4 or pattern\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:44
S90	573	S89 and opening	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:44
S91	392	S90 and ((@ad<"20030912") or (@rlad<"20030912"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:14
S92	133	S91 and photolithography	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:45

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S93	125	S92 and semiconductor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:51
S94	92568	Mui.in. or Liu.in. or Deshmukh.in. or "Sasano.in"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:51
S95	28060	Applied.as.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:52
S96	119929	S94 or S95	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:52
S97	605	S96 and (control\$4 near20 (CD or (critical near dimension)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:52
S98	441	S97 and ((@ad<"20030912") or (@rlad<"20030912"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:54
S99	431	S98 not S93	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 12:54
S10 0	10	("20030216026" "5407524" "6042999" "6080529" "6194128" "6207554" "6319821" "6372631" "6630407" "6774031").PN. OR ("7253115"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 13:22

S10 1	43	("4256534" "4440804" "4444618" "4447824" "4474642" "4519872" "4753709" "4832788" "4863557" "4966865" "5053105" "5067002" "5110712" "5141817" "5183972" "5186718" "5286344" "5326431" "5346586" "5356511" "5387556" "5445710" "5476753" "5550405" "5559056" "5578166" "5880018").PN. OR ("6143476").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 15:54
S10 2	59	(feedback same (feed-back)) same ((critical near4 dimension) or CD)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 16:52
S10 3	571	(156/345.24).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 16:58
S10 4	17	S103 and ((feedback or feed-back) near20 (opening or via or trench or recess or groove or aperture or hole))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 17:20
S10 5	17585	(determin\$4 or check\$4 or measur\$4 or assur\$4) near8 (CD! or (critical near dimension))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 17:21
S10 6	322	S105 and S96	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 17:21
S10 7	237	S106 and ((@ad<"20030912") or (@rlad<"20030912"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/27 19:53

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S10 8	2	("5926690").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 19:53
S10 9	134	("5629772" "5655110" "5773174").PN. OR ("5926690"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 19:56
S11 0	9	("5109430" "5926690" "6245581" "6388253" "6424417" "6486492" "6689519" "6891627" "6961626").PN. OR ("7250309").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:03
S11 1	89	("5690785" "5885472" "6018688").PN. OR ("6245581"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:09
S11 2	1	S109 and Mak.in.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:38
S11 3	6	S109 and Mui.in.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:40
S11 4	162	S109 or S110 or S111	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:40
S11 5	103	S114 and feedback	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:40
S11 6	102	S115 and etch\$4	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/27 20:49
S11 7	2	("6225134").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 20:49
S11 8	2	("6309976").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 20:50

S11 9	2	("6235440").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 20:51
S12 0	2	("6161054").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/12/27 20:51

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	134	("5629772" "5655110" "5773174").PN. OR ("5926690"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 11:49
L2	9	("5109430" "5926690" "6245581" "6388253" "6424417" "6486492" "6689519" "6891627" "6961626").PN. OR ("7250309").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 11:49
L3	89	("5690785" "5885472" "6018688").PN. OR ("6245581"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 11:49
L4	162	L1 or L2 or L3	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 11:49
L34	67699	(within near8 specification)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:52
L35	25	4 and 34	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/12/28 11:52
L36	89	("5690785" "5885472" "6018688").PN. OR ("6245581"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:12
L37	46012	(etch\$4 or creat\$4 or pattern\$4) near8 (opening or via or trench or groove or recess or aperture or hole) near8 (resist or PR or P/R or photoresist or photo-resist)	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:13
L38	936	measuring near8 (critical near dimension)	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:14
L39	129	37 and 38	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:14
L40	93	39 and ((@ad<"20030912") or (@rlad<"20030912"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:14

L41	17	("4529860" "4800251" "4938839" "4959326" "5200360" "5246799" "5258093" "5259924" "5380608" "5393374" "5637186" "5783099" "5783366" "5798303" "5880019" "5976968").PN. OR ("6309976"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:43
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